

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/608,159	<b>Applicant(s)/Patent under Reexamination</b> WU, JUNG-JYH
<b>Examiner</b> Kien T. Nguyen	<b>Art Unit</b> 3714	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
446	227-259	4/18/05	KW